

## IN THE U.S. PATENT AND TRADEMARK OFFICE

In re application of

Kazuhiro NAKAJIMA et al.

Conf. 9942

Application No. 10/625,695

Group 2811

Filed July 24, 2003

Examiner Ori Nadav

PRODUCTION PROCESS FOR PRODUCING SEMICONDUCTOR DEVICES, SEMICONDUCTOR DEVICES PRODUCED THEREBY, AND TEST SYSTEM FOR CARRYING OUT YIELD-RATE TEST IN PRODUCTION OF SUCH SEMICONDUCTOR DEVICES

## AMENDMENT AFTER FINAL REJECTION

Assistant Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450 November 3, 2006

Sir:

In response to the Official Action mailed May 9, 2006, please amend the above-identified application as follows:

Amendments to the Claims are reflected in the listing of claims which begins on page 2 of this paper.

Remarks begin on page 9 of this paper.

OK to enter

ON. "holo6